

Day : Wednesday

Date: 11/29/2006

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PALM INTRANET

Inventor Name Search Result

Your Search was:

Last Name = SMILANSKY

First Name = ZEEV

Application#	Patent#	Status	Date Filed	Title	Inventor Name
07650468	5339176	150	02/04/1991	APPARATUS AND METHOD FOR COLOR CALIBRATION	SMILANSKY, ZEEV
08122507	5495535	150	09/24/1993	METHOD OF INSPECTING ARTICLES	SMILANSKY, ZEEV
08172592	Not Issued	161	12/21/1993	APPARATUS AND METHOD FOR COLOR CALIBRATION	SMILANSKY, ZEEV
08405938	5774573	150	03/17/1995	AUTOMATIC VISUAL INSPECTION SYSTEM	SMILANSKY, ZEEV
09110870	6366690	150	07/07/1998	PIXEL BASED MACHINE FOR PATTERNED WAFERS	SMILANSKY, ZEEV
09270924	6323856	250	03/16/1999	METHOD FOR PROCESSING VARIABLE SPEED SCENES FOR COMPUTER GAMES	SMILANSKY, ZEEV
09377347	Not Issued	161	08/19/1999	METHOD AND APPARATUS FOR INSPECTION OF PRINTED CIRCUIT BOARDS	SMILANSKY, ZEEV
09607343	RE38559	150	06/30/2000	AUTOMATIC VISUAL INSPECTION SYSTEM	SMILANSKY, ZEEV
09633756	Not Issued	93	08/07/2000	APPARATUS AND METHODS FOR THE INSPECTION OF OBJECTS	SMILANSKY, ZEEV
09782626	Not Issued	71	02/13/2001	Multiple optical input inspection system	SMILANSKY, ZEEV
10003347	7016526	150	12/06/2001	PIXEL BASED MACHINE FOR PATTERNED WAFERS	SMILANSKY, ZEEV
10056483	Not Issued	161	01/28/2002	Method for comparing signal arrays in digital images	SMILANSKY, ZEEV
10148162	Not	164	10/03/2002	METHOD FOR	SMILANSKY, ZEEV

	Issued			REGISTERING SEPARATION PATTERNS	
10281125	Not Issued	161	10/28/2002	Pixel based machine for patterned wafers	SMILANSKY, ZEEV
10281229	6810139	150	10/28/2002	PIXEL BASED MACHINE FOR PATTERNED WAFERS	SMILANSKY, ZEEV
10399018	Not Issued	41	07/15/2003	Method for determining mass altering moiety in peptides	SMILANSKY, ZEEV
10537071	Not Issued	30	01/09/2006	Protein synthesis monitoring (psm)	SMILANSKY, ZEEV
10658819	Not Issued	30	09/08/2003	Miniature autonomous agents for scene interpretation	SMILANSKY, ZEEV
10706440	Not Issued	93	11/12/2003	APPARATUS AND METHODS FOR THE INSPECTION OF OBJECTS	SMILANSKY, ZEEV
10706489	Not Issued	41	11/12/2003	Apparatus and methods for the inspection of objects	SMILANSKY, ZEEV
11042084	Not Issued	71	01/26/2005	Pixel based machine for patterned wafers	SMILANSKY, ZEEV
11042509	Not Issued	30	01/26/2005	Pixel based machine for patterned wafers	SMILANSKY, ZEEV
60429532	Not Issued	159	11/29/2002	Protein synthesis monitoring (PSM)	SMILANSKY, ZEEV
60574210	Not Issued	159	05/26/2004	Measuring RNA by protein synthesis monitoring (PSM)	SMILANSKY, ZEEV
60737379	Not Issued	159	11/17/2005	System and methods for measuring general translation activity in viable cells	SMILANSKY, ZEEV
60847380	Not Issued	20	09/27/2006	System and methods for measuring general translation activity in viable cells	SMILANSKY, ZEEV

Inventor Search Completed: No Records to Display.

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